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Understanding Embedded - Microprocessors

Embedded microprocessors are specialized computing chips designed to perform specific tasks within an embedded system. Unlike general-purpose microprocessors found in personal computers, embedded microprocessors are tailored for dedicated functions within larger systems, offering optimized performance, efficiency, and reliability. These microprocessors are integral to the operation of countless electronic devices, providing the computational power necessary for controlling processes, handling data, and managing communications.

Applications of **Embedded - Microprocessors**

Embedded microprocessors are utilized across a broad spectrum of applications, making them indispensable in

Details

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Product Status	Obsolete
Core Processor	PowerPC e500
Number of Cores/Bus Width	1 Core, 32-Bit
Speed	1.0GHz
Co-Processors/DSP	Signal Processing; SPE, Security; SEC
RAM Controllers	DDR, DDR2, SDRAM
Graphics Acceleration	No
Display & Interface Controllers	-
Ethernet	10/100/1000Mbps (4)
SATA	-
USB	-
Voltage - I/O	1.8V, 2.5V, 3.3V
Operating Temperature	0°C ~ 105°C (TA)
Security Features	Cryptography, Random Number Generator
Package / Case	783-BBGA, FCBGA
Supplier Device Package	783-FCBGA (29x29)
Purchase URL	https://www.e-xfl.com/pro/item?MUrl=&PartUrl=mpc8545ehxaqg

Email: info@E-XFL.COM

Address: Room A, 16/F, Full Win Commercial Centre, 573 Nathan Road, Mongkok, Hong Kong

Overview

- Single inbound doorbell message structure
- Facility to accept port-write messages
- PCI Express interface
 - PCI Express 1.0a compatible
 - Supports x8,x4,x2, and x1 link widths
 - Auto-detection of number of connected lanes
 - Selectable operation as root complex or endpoint
 - Both 32- and 64-bit addressing
 - 256-byte maximum payload size
 - Virtual channel 0 only
 - Traffic class 0 only
 - Full 64-bit decode with 32-bit wide windows
- Pin multiplexing for the high-speed I/O interfaces supports one of the following configurations:
 - 8 PCI Express
 - 4 PCI Express and 4 serial RapidIO
- Power management
 - Supports power saving modes: doze, nap, and sleep
 - Employs dynamic power management, which automatically minimizes power consumption of blocks when they are idle
- System performance monitor
 - Supports eight 32-bit counters that count the occurrence of selected events
 - Ability to count up to 512 counter-specific events
 - Supports 64 reference events that can be counted on any of the eight counters
 - Supports duration and quantity threshold counting
 - Burstiness feature that permits counting of burst events with a programmable time between bursts
 - Triggering and chaining capability
 - Ability to generate an interrupt on overflow
- System access port
 - Uses JTAG interface and a TAP controller to access entire system memory map
 - Supports 32-bit accesses to configuration registers
 - Supports cache-line burst accesses to main memory
 - Supports large block (4-Kbyte) uploads and downloads
 - Supports continuous bit streaming of entire block for fast upload and download
- JTAG boundary scan, designed to comply with IEEE Std. 1149.1TM

Table 13 provides the recommended operating conditions for the DDR SDRAM controller when $GV_{DD}(typ) = 2.5 \text{ V}.$

Parameter/Condition	Symbol	Symbol Min		Unit	Notes
I/O supply voltage	GV _{DD}	2.375	2.625	V	1
I/O reference voltage	MV _{REF}	MV_{REF} 0.49 × GV_{DD}		V	2
I/O termination voltage	V _{TT}	MV _{REF} – 0.04	MV _{REF} + 0.04	V	3
Input high voltage	V _{IH}	MV _{REF} + 0.15	GV _{DD} + 0.3	V	—
Input low voltage	V _{IL}	-0.3	MV _{REF} – 0.15	V	—
Output leakage current	I _{OZ}	-50	50	μΑ	4
Output high current (V _{OUT} = 1.95 V)	I _{OH}	-16.2	—	mA	—
Output low current (V _{OUT} = 0.35 V)	I _{OL}	16.2	—	mA	—

Table 13. DDR SDRAM DC Electrical	Characteristics for GV _{DD} (typ) = 2.5 V

Notes:

1. ${\rm GV}_{\rm DD}$ is expected to be within 50 mV of the DRAM ${\rm V}_{\rm DD}$ at all times.

2. MV_{REF} is expected to be equal to 0.5 × GV_{DD}, and to track GV_{DD} DC variations as measured at the receiver. Peak-to-peak noise on MV_{REF} may not exceed ±2% of the DC value.

3. V_{TT} is not applied directly to the device. It is the supply to which far end signal termination is made and is expected to be equal to MV_{REF}. This rail must track variations in the DC level of MV_{REF}.

4. Output leakage is measured with all outputs disabled, $0 V \le V_{OUT} \le GV_{DD}$.

Table 14 provides the DDR I/O capacitance when $GV_{DD}(typ) = 2.5$ V.

Table 14. DDR SDRAM Capacitance for GV_{DD}(typ) = 2.5 V

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Input/output capacitance: DQ, DQS	C _{IO}	6	8	pF	1
Delta input/output capacitance: DQ, DQS	C _{DIO}		0.5	pF	1

Note:

1. This parameter is sampled. $GV_{DD} = 2.5 \text{ V} \pm 0.125 \text{ V}$, f = 1 MHz, T_A = 25°C, $V_{OUT} = GV_{DD}/2$, V_{OUT} (peak-to-peak) = 0.2 V.

This table provides the current draw characteristics for MV_{REF}.

Table 15. Current Draw Characteristics for MV_{REF}

Parameter/Condition	Symbol	Min	Max	Unit	Notes
Current draw for MV _{REF}	I _{MVREF}		500	μA	1

Note:

1. The voltage regulator for MV_{REF} must be able to supply up to 500 μ A current.



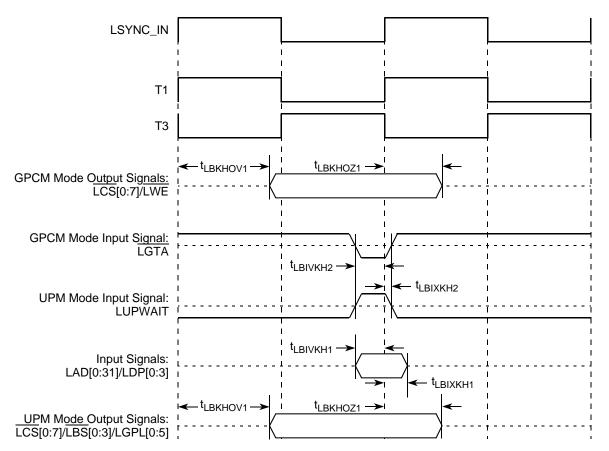


Figure 25. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 4 (PLL Enabled)

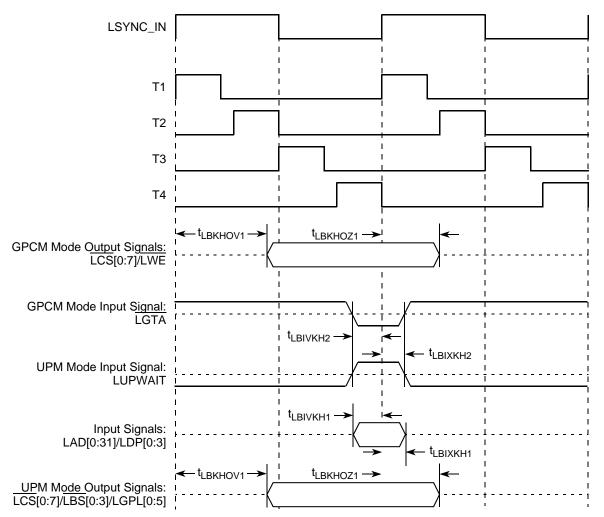


Figure 27. Local Bus Signals, GPCM/UPM Signals for LCCR[CLKDIV] = 8 or 16 (PLL Enabled)

l²C

13 I²C

This section describes the DC and AC electrical characteristics for the I²C interfaces of the device.

13.1 I²C DC Electrical Characteristics

This table provides the DC electrical characteristics for the I^2C interfaces.

Table 45. I²C DC Electrical Characteristics

Parameter	Symbol	Min	Мах	Unit	Notes
Input high voltage level	V _{IH}	$0.7 \times OV_{DD}$	OV _{DD} + 0.3	V	_
Input low voltage level	V _{IL}	-0.3	$0.3 imes OV_{DD}$	V	—
Low level output voltage	V _{OL}	0	$0.2 \times \text{OV}_{\text{DD}}$	V	1
Pulse width of spikes which must be suppressed by the input filter	t _{I2KHKL}	0	50	ns	2
Input current each I/O pin (input voltage is between $0.1 \times OV_{DD}$ and $0.9 \times OV_{DD}$ (max)	I	-10	10	μΑ	3
Capacitance for each I/O pin	Cl	—	10	pF	—

Notes:

1. Output voltage (open drain or open collector) condition = 3 mA sink current.

- 2. See the MPC8548E PowerQUICC[™] III Integrated Processor Family Reference Manual, for information on the digital filter used.
- 3. I/O pins obstruct the SDA and SCL lines if $\ensuremath{\mathsf{OV}_{\mathsf{DD}}}$ is switched off.

13.2 I²C AC Electrical Specifications

This table provides the AC timing parameters for the I^2C interfaces.

Table 46. I²C AC Electrical Specifications

Parameter	Symbol ¹	Min	Max	Unit	Notes
SCL clock frequency	f _{I2C}	0	400	kHz	—
Low period of the SCL clock	t _{I2CL}	1.3	—	μS	4
High period of the SCL clock	t _{I2CH}	0.6	—	μS	4
Setup time for a repeated START condition	t _{I2SVKH}	0.6	—	μS	4
Hold time (repeated) START condition (after this period, the first clock pulse is generated)	t _{I2SXKL}	0.6	—	μS	4
Data setup time	t _{I2DVKH}	100	—	ns	4
Data input hold time: CBUS compatible masters I ² C bus devices	t _{I2DXKL}	0		μs	2
Data output delay time:	t _{I2OVKL}	—	0.9	—	3
Set-up time for STOP condition	t _{I2PVKH}	0.6	—	μS	—
Bus free time between a STOP and START condition	t _{I2KHDX}	1.3		μS	



Figure 34 shows the AC timing diagram for the I^2C bus.

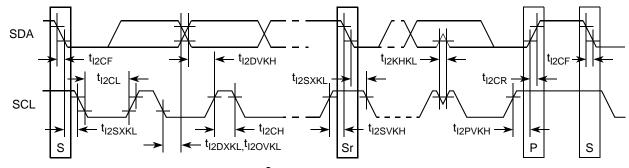
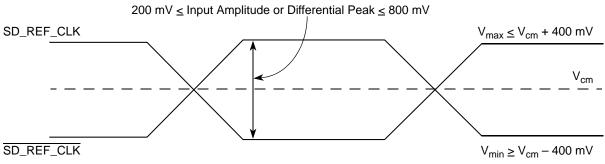


Figure 34. I²C Bus AC Timing Diagram

High-Speed Serial Interfaces (HSSI)





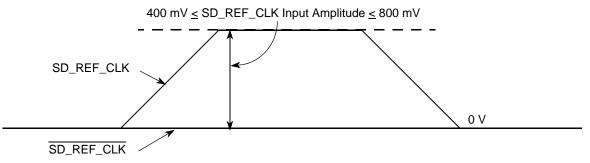


Figure 42. Single-Ended Reference Clock Input DC Requirements

16.2.3 Interfacing with Other Differential Signaling Levels

- With on-chip termination to SGND_SRDSn (xcorevss), the differential reference clocks inputs are HCSL (high-speed current steering logic) compatible DC-coupled.
- Many other low voltage differential type outputs like LVDS (low voltage differential signaling) can be used but may need to be AC-coupled due to the limited common mode input range allowed (100 to 400 mV) for DC-coupled connection.
- LVPECL outputs can produce signal with too large amplitude and may need to be DC-biased at clock driver output first, then followed with series attenuation resistor to reduce the amplitude, in addition to AC-coupling.

NOTE

Figure 43 through Figure 46 below are for conceptual reference only. Due to the fact that clock driver chip's internal structure, output impedance, and termination requirements are different between various clock driver chip manufacturers, it is very possible that the clock circuit reference designs provided by clock driver chip vendor are different from what is shown below. They might also vary from one vendor to the other. Therefore, Freescale Semiconductor can neither provide the optimal clock driver reference circuits, nor guarantee the correctness of the following clock driver connection reference circuits. The system designer is recommended to contact the selected clock driver chip vendor for the optimal reference circuits with the SerDes reference clock receiver requirement provided in this document.

Serial RapidIO

Characteristic	Symbol	Ra	nge	Unit	Notes
Characteristic	Symbol	Min	Max	Unit	Notes
Output voltage	Vo	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	V _{DIFFPP}	500	1000	mV p-p	—
Deterministic jitter	J _D	—	0.17	UI p-p	—
Total jitter	J _T	—	0.35	UI p-p	—
Multiple output skew	S _{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	400	400	ps	±100 ppm

Table 61. Short Run Transmitter AC Timing Specifications—3.125 GBaud

Characteristic	Symbol	Rai	nge	Unit	Notes
Characteristic	Symbol	Min	Max	Onic	NOICS
Output voltage	Vo	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	V _{DIFFPP}	500	1000	mVp-p	-
Deterministic jitter	J _D	—	0.17	UI p-p	-
Total jitter	J _T	—	0.35	UI p-p	_
Multiple output skew	S _{MO}	—	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	320	320	ps	±100 ppm

Table 62. Long Run Transmitter AC Timing Specifications—1.25 GBaud

Characteristic	Symbol	Rai	nge	Unit	Notes
Characteristic	Symbol	Min	Max	Onit	NULES
Output voltage	V _O	-0.40	2.30	V	Voltage relative to COMMON of either signal comprising a differential pair
Differential output voltage	V _{DIFFPP}	800	1600	mVp-p	—
Deterministic jitter	J _D	—	0.17	UI p-p	—
Total jitter	J _T	—	0.35	UI p-p	—
Multiple output skew	S _{MO}	_	1000	ps	Skew at the transmitter output between lanes of a multilane link
Unit interval	UI	800	800	ps	±100 ppm

Characteristic	Symbol	Range		Unit	Notes	
Characteristic	Symbol	Min	Max	Onit	NOICES	
Differential input voltage	V _{IN}	200	1600	mVp-p	Measured at receiver	
Deterministic jitter tolerance	J _D	0.37	—	UI p-p	Measured at receiver	
Combined deterministic and random jitter tolerance	J _{DR}	0.55	—	UI p-p	Measured at receiver	
Total jitter tolerance ¹	J _T	0.65	_	UI p-p	Measured at receiver	
Multiple input skew	S _{MI}	_	22	ns	Skew at the receiver input between lanes of a multilane link	
Bit error rate	BER	_	10 ⁻¹²		—	
Unit interval	UI	320	320	ps	±100 ppm	

Table 68. Receiver	AC Timing	Specifications-	-3.125 GBaud
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Note:

1. Total jitter is composed of three components, deterministic jitter, random jitter and single frequency sinusoidal jitter. The sinusoidal jitter may have any amplitude and frequency in the unshaded region of Figure 53. The sinusoidal jitter component is included to ensure margin for low frequency jitter, wander, noise, crosstalk and other variable system effects.

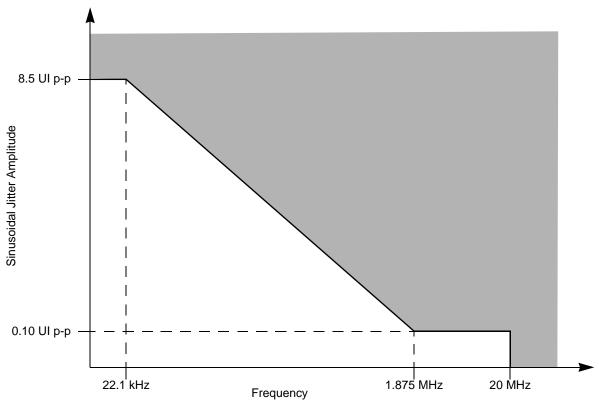


Figure 53. Single Frequency Sinusoidal Jitter Limits

Notes:

- 1. All dimensions are in millimeters.
- 2. Dimensioning and tolerancing per ASME Y14.5M-1994.
- 3. Maximum solder ball diameter measured parallel to datum A.
- 4. Datum A, the seating plane, is determined by the spherical crowns of the solder balls.
- 5. Parallelism measurement shall exclude any effect of mark on top surface of package.
- 6. All dimensions are symmetric across the package center lines unless dimensioned otherwise.

Signal	Package Pin Number	Pin Type	Power Supply	Notes
PCI1_REQ[4:1]	AH2, AG4, AG3, AH4	I	OV _{DD}	
PCI1_REQ0	AH3	I/O	OV _{DD}	—
PCI1_CLK	AH26	I	OV _{DD}	39
PCI1_DEVSEL	AH11	I/O	OV _{DD}	2
PCI1_FRAME	AE11	I/O	OV _{DD}	2
PCI1_IDSEL	AG9	I	OV _{DD}	
PCI1_REQ64/PCI2_FRAME	AF14	I/O	OV _{DD}	2, 5, 10
PCI1_ACK64/PCI2_DEVSEL	V15	I/O	OV _{DD}	2
PCI2_CLK	AE28	I	OV _{DD}	39
PCI2_IRDY	AD26	I/O	OV _{DD}	2
PCI2_PERR	AD25	I/O	OV _{DD}	2
PCI2_GNT[4:1]	AE26, AG24, AF25, AE25	0	OV _{DD}	5, 9, 35
PCI2_GNT0	AG25	I/O	OV _{DD}	—
PCI2_SERR	AD24	I/O	OV _{DD}	2, 4
PCI2_STOP	AF24	I/O	OV _{DD}	2
PCI2_TRDY	AD27	I/O	OV _{DD}	2
PCI2_REQ[4:1]	AD28, AE27, W17, AF26	I	OV _{DD}	—
PCI2_REQ0	AH25	I/O	OV _{DD}	—
	DDR SDRAM Memory Interface		•	
MDQ[0:63]	L18, J18, K14, L13, L19, M18, L15, L14, A17, B17, A13, B12, C18, B18, B13, A12, H18, F18, J14, F15, K19, J19, H16, K15, D17, G16, K13, D14, D18, F17, F14, E14, A7, A6, D5, A4, C8, D7, B5, B4, A2, B1, D1, E4, A3, B2, D2, E3, F3, G4, J5, K5, F6, G5, J6, K4, J1, K2, M5, M3, J3, J2, L1, M6	I/O	GV _{DD}	_
MECC[0:7]	H13, F13, F11, C11, J13, G13, D12, M12	I/O	GV _{DD}	
MDM[0:8]	M17, C16, K17, E16, B6, C4, H4, K1, E13	0	GV _{DD}	-
MDQS[0:8]	M15, A16, G17, G14, A5, D3, H1, L2, C13	I/O	GV _{DD}	-
MDQS[0:8]	L17, B16, J16, H14, C6, C2, H3, L4, D13	I/O	GV _{DD}	—
MA[0:15]	A8, F9, D9, B9, A9, L10, M10, H10, K10, G10, B8, E10, B10, G6, A10, L11	0	GV _{DD}	—
MBA[0:2]	F7, J7, M11	0	GV _{DD}	—

Table 71. MPC8548E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	Clock			1
RTC	AF16	I	OV _{DD}	—
SYSCLK	AH17	I	OV _{DD}	—
	JTAG			1
ТСК	AG28	I	OV _{DD}	—
TDI	AH28	I	OV _{DD}	12
TDO	AF28	0	OV _{DD}	_
TMS	AH27	I	OV _{DD}	12
TRST	AH23	I	OV _{DD}	12
	DFT			
L1_TSTCLK	AC25	I	OV _{DD}	25
L2_TSTCLK	AE22	I	OV _{DD}	25
LSSD_MODE	AH20	I	OV _{DD}	25
TEST_SEL	AH14	I	OV _{DD}	25
	Thermal Management			
THERM0	AG1	—	_	14
THERM1	AH1	_		14
	Power Management			
ASLEEP	AH18	0	OV _{DD}	9, 19, 29
	Power and Ground Signals			•
GND	 A11, B7, B24, C1, C3, C5, C12, C15, C26, D8, D11, D16, D20, D22, E1, E5, E9, E12, E15, E17, F4, F26, G12, G15, G18, G21, G24, H2, H6, H8, H28, J4, J12, J15, J17, J27, K7, K9, K11, K27, L3, L5, L12, L16, N11, N13, N15, N17, N19, P4, P9, P12, P14, P16, P18, R11, R13, R15, R17, R19, T4, T12, T14, T16, T18, U8, U11, U13, U15, U17, U19, V4, V12, V18, W6, W19, Y4, Y9, Y11, Y19, AA6, AA14, AA17, AA22, AA23, AB4, AC2, AC11, AC19, AC26, AD5, AD9, AD22, AE3, AE14, AF6, AF10, AF13, AG8, AG27, K28, L24, L26, N24, N27, P25, R28, T24, T26, U24, V25, W28, Y24, Y26, AA24, AA27, AB25, AC28, L21, L23, N22, P20, R23, T21, U22, V20, W23, Y21, U27 	_		
OV _{DD}	V16, W11, W14, Y18, AA13, AA21, AB11, AB17, AB24, AC4, AC9, AC21, AD6, AD13, AD17, AD19, AE10, AE8, AE24, AF4, AF12, AF22, AF27, AG26	Power for PCI and other standards (3.3 V)	OV _{DD}	_

Table 72. MPC8547E Pinout Listing (continued	I)
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Signal	Package Pin Number	Pin Type	Power Supply	Notes
Reserved	U20, V22, W20, Y22	_		15
Reserved	U21, V23, W21, Y23	—	—	15
SD_PLL_TPD	U28	0	XV _{DD}	24
SD_REF_CLK	T28	I	XV _{DD}	—
SD_REF_CLK	T27	I	XV _{DD}	—
Reserved	AC1, AC3	—	_	2
Reserved	M26, V28	—	—	32
Reserved	M25, V27	—	—	34
Reserved	M20, M21, T22, T23	—	—	38
· · · · ·	General-Purpose Output			•
GPOUT[24:31]	K26, K25, H27, G28, H25, J26, K24, K23	0	BV _{DD}	—
	System Control			•
HRESET	AG17	I	OV _{DD}	—
HRESET_REQ	AG16	0	OV _{DD}	29
SRESET	AG20	I	OV _{DD}	—
CKSTP_IN	AA9	I	OV _{DD}	—
CKSTP_OUT	AA8	0	OV _{DD}	2, 4
	Debug			
TRIG_IN	AB2	I	OV _{DD}	—
TRIG_OUT/READY/QUIESCE	AB1	0	OV _{DD}	6, 9, 19, 29
MSRCID[0:1]	AE4, AG2	0	OV _{DD}	5, 6, 9
MSRCID[2:4]	AF3, AF1, AF2	0	OV _{DD}	6, 19, 29
MDVAL	AE5	0	OV _{DD}	6
CLK_OUT	AE21	0	OV _{DD}	11
	Clock	-		
RTC	AF16	I	OV _{DD}	—
SYSCLK	AH17	I	OV _{DD}	—
	JTAG	•		
ТСК	AG28	I	OV _{DD}	—
TDI	AH28	I	OV _{DD}	12
TDO	AF28	0	OV _{DD}	—
TMS	AH27	I	OV _{DD}	12
TRST	AH23	I	OV _{DD}	12

Signal	Package Pin Number	Pin Type	Power Supply	Notes
SD_IMP_CAL_RX	L28	I	200 Ω to GND	—
SD_IMP_CAL_TX	AB26	I	100 Ω to GND	—
SD_PLL_TPA	U26	0	—	24

Table 73. MPC8545E Pinout Listing (continued)

Note: All note references in this table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Table 74 provides the pin-out listing for the MPC8543E 783 FC-PBGA package.

NOTE

All note references in the following table use the same numbers as those for Table 71. See Table 71 for the meanings of these notes.

Table 74. MPC8543E Pinout Listing

Signal	Package Pin Number	Pin Type	Power Supply	Notes
	PCI1 (One 32-Bit)			•
Reserved	AB14, AC15, AA15, Y16, W16, AB16, AC16, AA16, AE17, AA18, W18, AC17, AD16, AE16, Y17, AC18,		_	110
GPOUT[8:15]	AB18, AA19, AB19, AB21, AA20, AC20, AB20, AB22	0	OV _{DD}	—
GPIN[8:15]	AC22, AD21, AB23, AF23, AD23, AE23, AC23, AC24	I	OV _{DD}	111
PCI1_AD[31:0]	AH6, AE7, AF7, AG7, AH7, AF8, AH8, AE9, AH9, AC10, AB10, AD10, AG10, AA10, AH10, AA11, AB12, AE12, AG12, AH12, AB13, AA12, AC13, AE13, Y14, W13, AG13, V14, AH13, AC14, Y15, AB15	I/O	OV _{DD}	17
Reserved	AF15, AD14, AE15, AD15	_	-	110
PCI1_C_BE[3:0]	AF9, AD11, Y12, Y13	I/O	OV _{DD}	17
Reserved	W15			110
PCI1_GNT[4:1]	AG6, AE6, AF5, AH5	0	OV _{DD}	5, 9, 35
PCI1_GNT0	AG5	I/O	OV _{DD}	—
PCI1_IRDY	AF11	I/O	OV _{DD}	2
PCI1_PAR	AD12	I/O	OV _{DD}	—
PCI1_PERR	AC12	I/O	OV _{DD}	2
PCI1_SERR	V13	I/O	OV _{DD}	2, 4
PCI1_STOP	W12	I/O	OV _{DD}	2

Signal	Package Pin Number	Pin Type	Power Supply	Notes
GPOUT[0:5]	N9, N10, P8, N7, R9, N5	0	LV _{DD}	
cfg_dram_type0/GPOUT6	R8	0	LV _{DD}	5, 9
GPOUT7	N6	0	LV _{DD}	-
Reserved	P1	—	_	104
Reserved	R6	—	_	104
Reserved	P6	—	—	15
Reserved	N4	—	_	105
FIFO1_RXC2	P5	I	LV _{DD}	104
Reserved	R1	—	_	104
Reserved	P10	—	_	105
FIFO1_TXC2	P7	0	LV _{DD}	15
cfg_dram_type1	R10	0	LV _{DD}	5, 9
Thre	ee-Speed Ethernet Controller (Gigabit	Ethernet 3)		
TSEC3_TXD[3:0]	V8, W10, Y10, W7	0	TV _{DD}	5, 9, 2
TSEC3_RXD[3:0]	Y1, W3, W5, W4	I	TV _{DD}	_
TSEC3_GTX_CLK	W8	0	TV _{DD}	_
TSEC3_RX_CLK	W2	I	TV _{DD}	—
TSEC3_RX_DV	W1	I	TV _{DD}	_
TSEC3_RX_ER	Y2	I	TV _{DD}	_
TSEC3_TX_CLK	V10	I	TV _{DD}	_
TSEC3_TX_EN	V9	0	TV _{DD}	30
TSEC3_TXD[7:4]	AB8, Y7, AA7, Y8	0	TV _{DD}	5, 9, 2
TSEC3_RXD[7:4]	AA1, Y3, AA2, AA4	I	TV _{DD}	_
Reserved	AA5	_	_	15
TSEC3_COL	Y5	I	TV _{DD}	- 1
TSEC3_CRS	AA3	I/O	TV _{DD}	31
TSEC3_TX_ER	AB6	0	TV _{DD}	- 1
	DUART	1		
UART_CTS[0:1]	AB3, AC5	I	OV _{DD}	-
UART_RTS[0:1]	AC6, AD7	0	OV _{DD}	1 -
UART_SIN[0:1]	AB5, AC7	I	OV _{DD}	<u> </u>
UART_SOUT[0:1]	AB7, AD8	0	OV _{DD}	<u> </u>
	I ² C interface	I		_1
IIC1_SCL	AG22	I/O	OV _{DD}	4, 27
				_1

Table 74. MPC8543E Pinout Listing (continued)

Signal	Package Pin Number	Pin Type	Power Supply	Notes
IIC1_SDA	AG21	I/O	OV _{DD}	4, 27
IIC2_SCL	AG15	I/O	OV _{DD}	4, 27
IIC2_SDA	AG14	I/O	OV _{DD}	4, 27
	SerDes	1		
SD_RX[0:7]	M28, N26, P28, R26, W26, Y28, AA26, AB28	Ι	XV _{DD}	—
SD_RX[0:7]	M27, N25, P27, R25, W25, Y27, AA25, AB27	I	XV _{DD}	_
SD_TX[0:7]	M22, N20, P22, R20, U20, V22, W20, Y22	0	XV _{DD}	—
SD_TX[0:7]	M23, N21, P23, R21, U21, V23, W21, Y23	0	XV _{DD}	_
SD_PLL_TPD	U28	0	XV _{DD}	24
SD_REF_CLK	T28	Ι	XV _{DD}	—
SD_REF_CLK	T27	Ι	XV _{DD}	_
Reserved	AC1, AC3	—	_	2
Reserved	M26, V28	_	—	32
Reserved	M25, V27	_	_	34
Reserved	M20, M21, T22, T23	—	_	38
	General-Purpose Output			
GPOUT[24:31]	K26, K25, H27, G28, H25, J26, K24, K23	0	BV _{DD}	—
	System Control			
HRESET	AG17	Ι	OV _{DD}	—
HRESET_REQ	AG16	0	OV_DD	29
SRESET	AG20	I	OV _{DD}	—
CKSTP_IN	AA9	Ι	OV_{DD}	—
CKSTP_OUT	AA8	0	OV_{DD}	2, 4
	Debug			
TRIG_IN	AB2	Ι	OV _{DD}	—
TRIG_OUT/READY/QUIESCE	AB1	0	OV _{DD}	6, 9, 19, 29
MSRCID[0:1]	AE4, AG2	0	OV _{DD}	5, 6, 9
MSRCID[2:4]	AF3, AF1, AF2	0	OV _{DD}	6, 19, 29
MDVAL	AE5	0	OV_{DD}	6
CLK_OUT	AE21	0	OV _{DD}	11
	Clock			
RTC	AF16	Ι	OV_{DD}	—
SYSCLK	AH17	I	OV _{DD}	

Signal	Package Pin Number	Pin Type	Power Supply	Notes
TV _{DD}	W9, Y6	Power for TSEC3 and TSEC4 (2,5 V, 3.3 V)	TV _{DD}	_
GV _{DD}	B3, B11, C7, C9, C14, C17, D4, D6, D10, D15, E2, E8, E11, E18, F5, F12, F16, G3, G7, G9, G11, H5, H12, H15, H17, J10, K3, K12, K16, K18, L6, M4, M8, M13	Power for DDR1 and DDR2 DRAM I/O voltage (1.8 V,2.5 V)	GV _{DD}	_
BV _{DD}	C21, C24, C27, E20, E25, G19, G23, H26, J20	Power for local bus (1.8 V, 2.5 V, 3.3 V)	BV _{DD}	_
V _{DD}	M19, N12, N14, N16, N18, P11, P13, P15, P17, P19, R12, R14, R16, R18, T11, T13, T15, T17, T19, U12, U14, U16, U18, V17, V19	Power for core (1.1 V)	V _{DD}	-
SV _{DD}	L25, L27, M24, N28, P24, P26, R24, R27, T25, V24, V26, W24, W27, Y25, AA28, AC27	Core power for SerDes transceivers (1.1 V)	SV _{DD}	_
XV _{DD}	L20, L22, N23, P21, R22, T20, U23, V21, W22, Y20	Pad power for SerDes transceivers (1.1 V)	XV _{DD}	_
AVDD_LBIU	J28	Power for local bus PLL (1.1 V)	_	26
AVDD_PCI1	AH21	Power for PCI1 PLL (1.1 V)	_	26
AVDD_PCI2	AH22	Power for PCI2 PLL (1.1 V)	_	26
AVDD_CORE	AH15	Power for e500 PLL (1.1 V)	_	26
AVDD_PLAT	AH19	Power for CCB PLL (1.1 V)	_	26
AVDD_SRDS	U25	Power for SRDSPLL (1.1 V)	_	26
SENSEVDD	M14	0	V _{DD}	13

Table 74. MPC8543E Pinout Listing (continued)

20.3 e500 Core PLL Ratio

This table describes the clock ratio between the e500 core complex bus (CCB) and the e500 core clock. This ratio is determined by the binary value of LBCTL, LALE, and LGPL2 at power up, as shown in this table.

Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio	Binary Value of LBCTL, LALE, LGPL2 Signals	e500 core:CCB Clock Ratio	
000	4:1	100	2:1	
001	9:2	101	5:2	
010	Reserved	110	3:1	
011	3:2	111	7:2	

Table 82. e500	Core to CCB	Clock Ratio
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20.4 Frequency Options

Table 83This table shows the expected frequency values for the platform frequency when using a CCB clock to SYSCLK ratio in comparison to the memory bus clock speed.

CCB to SYSCLK Ratio	SYSCLK (MHz)								
	16.66	25	33.33	41.66	66.66	83	100	111	133.33
	Platform/CCB Frequency (MHz)								
2									
3								333	400
4						333	400	445	533
5					333	415	500		
6					400	500		-	
8				333	533		-		
9				375					
10			333	417					
12			400	500					
16		400	533						
20	333	500		-					

Table 83. Frequency Options of SYSCLK with Respect to Memory Bus Speeds

Note: Due to errata Gen 13 the max sys clk frequency must not exceed 100 MHz if the core clk frequency is below 1200 MHz.

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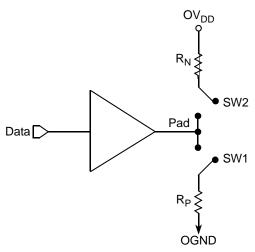


Figure 61. Driver Impedance Measurement

This table summarizes the signal impedance targets. The driver impedances are targeted at minimum V_{DD} , nominal OV_{DD} , 105°C.

Table 86. Impedance Characteristics

Impedance	Local Bus, Ethernet, DUART, Control, Configuration, Power Management	PCI	DDR DRAM	Symbol	Unit
R _N	43 Target	25 Target	20 Target	Z ₀	W
R _P	43 Target	25 Target	20 Target	Z ₀	W

Note: Nominal supply voltages. See Table 1, $T_i = 105^{\circ}C$.

22.8 Configuration Pin Muxing

The device provides the user with power-on configuration options which can be set through the use of external pull-up or pull-down resistors of $4.7 \text{ k}\Omega$ on certain output pins (see customer visible configuration pins). These pins are generally used as output only pins in normal operation.

While $\overline{\text{HRESET}}$ is asserted however, these pins are treated as inputs. The value presented on these pins while $\overline{\text{HRESET}}$ is asserted, is latched when $\overline{\text{HRESET}}$ deasserts, at which time the input receiver is disabled and the I/O circuit takes on its normal function. Most of these sampled configuration pins are equipped with an on-chip gated resistor of approximately 20 k Ω . This value must permit the 4.7-k Ω resistor to pull the configuration pin to a valid logic low level. The pull-up resistor is enabled only during $\overline{\text{HRESET}}$ (and for platform/system clocks after $\overline{\text{HRESET}}$ deassertion to ensure capture of the reset value). When the input receiver is disabled the pull-up is also, thus allowing functional operation of the pin as an output with minimal signal quality or delay disruption. The default value for all configuration bits treated this way has been encoded such that a high voltage level puts the device into the default state and external resistors are needed only when non-default settings are required by the user.

Careful board layout with stubless connections to these pull-down resistors coupled with the large value of the pull-down resistor minimizes the disruption of signal quality or speed for output pins thus configured.

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22.10 Guidelines for High-Speed Interface Termination

This section provides the guidelines for high-speed interface termination when the SerDes interface is entirely unused and when it is partly unused.

22.10.1 SerDes Interface Entirely Unused

If the high-speed SerDes interface is not used at all, the unused pin must be terminated as described in this section.

The following pins must be left unconnected (float):

- SD_TX[7:0]
- <u>SD_TX</u>[7:0]
- Reserved pins T22, T23, M20, M21

The following pins must be connected to GND:

- SD_RX[7:0]
- <u>SD_RX</u>[7:0]
- SD_REF_CLK
- SD_REF_CLK

NOTE

It is recommended to power down the unused lane through SRDSCR1[0:7] register (offset = $0xE_0F08$) (This prevents the oscillations and holds the receiver output in a fixed state.) that maps to SERDES lane 0 to lane 7 accordingly.

Pins V28 and M26 must be tied to XV_{DD} . Pins V27 and M25 must be tied to GND through a 300- Ω resistor.

In Rev 2.0 silicon, POR configuration pin cfg_srds_en on TSEC4_TXD[2]/TSEC3_TXD[6] can be used to power down SerDes block.

22.10.2 SerDes Interface Partly Unused

If only part of the high-speed SerDes interface pins are used, the remaining high-speed serial I/O pins must be terminated as described in this section.

The following pins must be left unconnected (float) if not used:

- SD_TX[7:0]
- <u>SD_TX</u>[7:0]
- Reserved pins: T22, T23, M20, M21

The following pins must be connected to GND if not used:

- SD_RX[7:0]
- $\overline{\text{SD}_{RX}}[7:0]$
- SD_REF_CLK